## Applicant(s)/Patent Under Application/Control No. Reexamination 09/823,449 HIEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2876 Daniel St.Cyr **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,612,532 03-1997 235/492 Iwasaki, Hiroshi US-6,575,361 06-2003 235/380 Graves et al. В US-С D US-Ε US-F US-US-G US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Classification Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS**

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